

规格书编号

**SPEC NO:** 

# 产品规格书 SPECIFICATION

CUSTOMER 客 户:						
PRODUCT 产品:	SAW FILTER					
MODEL NO 型 号:	HDF754A-F11					
PREPARED 编 制:	CHECKED 审 核	ξ̄:				
APPROVED 批准:	DATE日期	∃:2009-6-8				
客户确认 CUSTOMER RECEIVED:						
审核 CHECKED	批准 APPROVED	日期 DATE				

# 无锡市好达电子有限公司 Shoulder Electronics Limited



## 1. SCOPE

**SAW FILTER** 

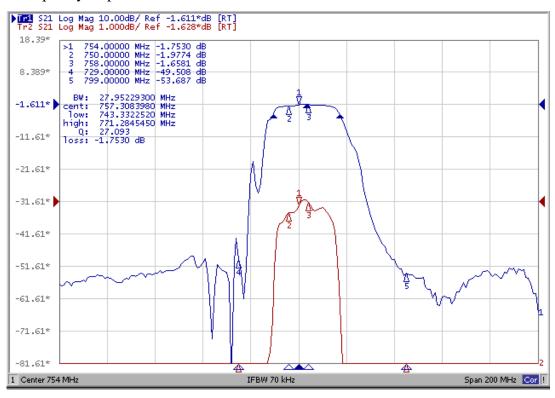
This specification shall cover the characteristics of SAW filter With HDF754A used for the page system.

## 2. ELECTRICAL SPECIFICATION

DC Voltage VDC	10V		
AC Voltage Vpp	10V50Hz/60Hz		
Operation temperature	-40°C to +85°C		
Storage temperature	-45°C to +85°C		

**Electronic Characteristics** 

#### 2-1. Typical frequency response

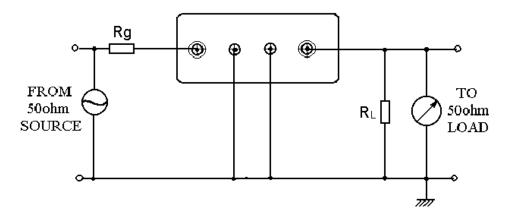


#### 2-2. Electrical characteristics

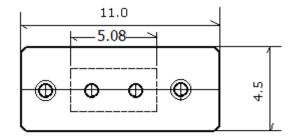
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	Unit	Minimum	Typical	Maximum		
Center Frequency	MHz	-	754	-		
Insertion Loss (In Fc +/- 4 MHz)	dB		2.5	3.0		
Amplitude Ripple (In Fc +/- 4 MHz)	dB		0.5	1.0		
Relative Attenuation						
0.3 MHz ~ Fo-25 MHz	dB	40	45	-		
Fo+45 MHz ~		40	45			
Input/Output Impedance	Ohms		50			

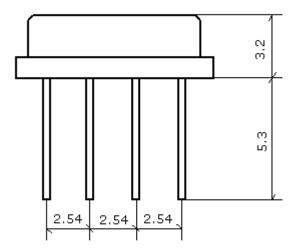
SAW FILTER HDF754A-F11

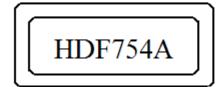
# 3. TEST CIRCUIT



## 4. DIMENSION











SAW FILTER HDF754A-F11

## 5. ENVIRONMENTAL CHARACTERISTICS

#### 5-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

#### 5-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

#### 5-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2-2.

#### 5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2-2.

#### 5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2-2.

#### 5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2-2.

#### 5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2-2.

#### 6. REMARK

#### 6.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

#### 6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

#### 6.3 Soldering

Only leads of component may be solded. Please avoid soldering another part of component.